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Application/Control No.	Applicant(s)/Patent under Reexamination
10/830,062	YAO ET AL.
Examiner	Art Unit
 Phuoc Tran	2624

SEARCHED					
Class	Subclass	Date	Examiner		
382	244, 247, 238	6/15/2007	PT		
358	426.13,				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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